

Automotive Power MOSFET Module

NXV08H400XT2

Features

- 2 Phase MOSFET Module
 At Customer Side this Module Can Be Used as 1/2 Bridge MOSFET Module by Combining 2 Phase Out Power Terminals
- Electrically Isolated DBC Substrate for Low Rthjc
- Compact Design for Low Total Module Resistance
- Module Serialization for Full Traceability
- Module Level AQG324 Qualified. Components Inside are AEC Q101 (MOSFET) & AEC Q200 (Passives) Qualified
- UL 94 V-0 Compliant
- This Device is Pb-Free and is RoHS Compliant

Applications

• 48 V Inverter, 48 V Traction

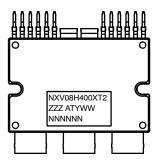
Benefits

- Enable Design of Small, Efficient and Reliable System for Reduced Vehicle Fuel Consumption and CO₂ Emission
- Simplified Vehicle Assembly
- Low Thermal Resistance to Junction to Heat Sink by Direct Mounting via Thermal Interface Material between Module Case and Heat Sink
- Low Inductance



APM17-MDA
CASE MODHU

MARKING DIAGRAM



NXV08H400XT2 = Specific Device Code

ZZZ = Lot ID

AT = Assembly & Test Location

Y = Year WW = Work Week NNN = Serial Number

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

1

ORDERING INFORMATION

Part Number	Package	Pb–Free and RoHS Compliant	Operating Ambient Temperature Range	Packing Method
NVX08H400XT2	APM17-MDA	yes	−40~125°C	Tube

Pin Configuration

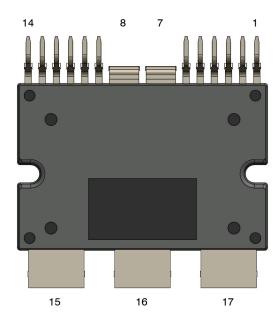


Figure 1. Pin Configuration

PIN DESCRIPTION

Pin No.	Description	Remark
1	Q2 Gate	
2	Q2 Source Sense	
3	B+ #2 Sense	
4	Q4 Gate	
5	Q4 Source Sense	
6	NTC1	
7	Phase Out2	For 3 phase motor inverter, those 2 pins can be used as one
8	Phase Out1	phase out
9	NTC2	
10	Q3 Source Sense	
11	Q3 Gate	
12	B+ #1 Sense	
13	Q1 Source Sense	
14	Q1 Gate	
15	B+ #1	
16	GND	
17	B+ #2	

Block Diagram

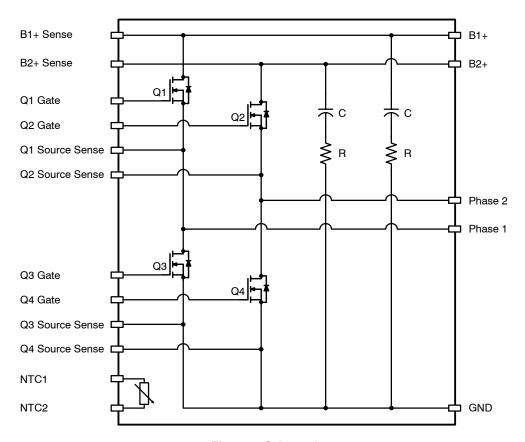


Figure 2. Schematic

Flammability Information

All materials present in the power module meet UL flammability rating class 94V–0.

Compliance to RoHS Directives

The power module is 100% lead free and RoHS compliant 2000/53/C directive.

Solder

Solder used is a lead free SnAgCu alloy.

Base of the leads, at the interface with the package body should not be exposed to more than 200°C during mounting on the PCB, this to prevent the remelt of the solder joints.

ABSOLUTE MAXIMUM RATINGS (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Max.	Unit
VDS(Q1~Q4)	Drain to Source Voltage	80	V
VGS(Q1~Q4)	Gate to Source Voltage	±20	V
EAS(Q1~Q4)	Single Pulse Avalanche Energy (Note 1)	2445	mJ
T _J	Maximum Junction Temperature	175	°C
T _{STG}	Storage Temperature	125	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

^{1.} Starting $T_J = 25^{\circ}C$, $\dot{L} = 0.47$ mH, $\dot{l}_{AS} = 102$ A, $\dot{V}_{DD} = 72$ V during inductor charging and $\dot{V}_{DD} = 0$ V during time in avalanche.

ELECTRICAL CHARACTERISTICS (T_J = 25°C, unless otherwise noted)

	Characteristic	Condition	Min	Тур	Max	Unit
BVDSS	Drain-to-Source Breakdown Voltage	I _D = 1 mA, V _{GS} = 0 V	80	-	_	
VGS(th)	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 1 \text{ mA}$	2	-	4.6	V
VSD	Source-to-Drain Diode Voltage	I _{SD} = 160 A, V _{GS} = 0 V	-	0.79	1.1	V
Measured RDS(ON) Q1, Q2	Q1, Q2 (High Side) MOSFET (Note 2) (Note 3)	$V_{GS} = 12 \text{ V}, I_D = 160 \text{ A}, T_J = 25^{\circ}\text{C}$	-	0.65	0.765	mΩ
Measured RDS(ON) Q3, Q4	Q3, Q4 (Low Side) MOSFET (Note 2) (Note 3)	$V_{GS} = 12 \text{ V}, I_D = 160 \text{ A}, T_J = 25^{\circ}\text{C}$	-	0.60	0.71	mΩ
Pure RDS(ON) Q1, Q2, Q3, Q4	Rdson Measurement with Kelvin pin with min impact of measurement path (Note 2)	$V_{GS} = 12 \text{ V}, I_D = 160 \text{ A}, T_J = 25^{\circ}\text{C}$	-	0.46	0.58	mΩ
IGSS	Gate-to-Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}, T_{J} = 25^{\circ}\text{C}$	-100	-	+100	nA
IDSS	Drain-to-Source Leakage Current	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 25^{\circ}\text{C}$	-	-	2	μΑ
Module RDS(ON) for Q1 From B+1 (or B+2), via Q (Note 3)	and Q2: 11 (or Q2), to Phase Out 1 (Phase Out 2)	$V_{GS} = 12 \text{ V}, I_D = 160 \text{ A}, T_J = 25^{\circ}\text{C}$	-	0.96	1.32	mΩ
Module RDS(ON) for Q3 From Phase Out 1 (Phas (Note 3)	and Q4: e Out 2), via Q3 (Q4), to GND PINs	V _{GS} = 12 V, I _D = 160 A, T _J = 25°C	-	0.9	1.25	mΩ

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

RESISTANCE MEASUREMENTS METHODS

	+ Force Pin#	- Force Pin#	+ Sense Pin#	- Sense Pin#
FET Rdson Q1	B1+	Phase1	B1+ Sense	Q1 Source Sense
FET Rdson Q2	B2+	Phase2	B2+ Sense	Q2 Source Sense
FET Rdson Q3	Phase1	GND	Q1 Source Sense	Q3 Source Sense
FET Rdson Q4	Phase2	GND	Q2 Source Sense	Q4 Source Sense
Module Rdson Q1	B1+	Phase1	B1+	Phase1
Module Rdson Q2	B2+	Phase2	B2+	Phase2
Module Rdson Q3	Phase1	GND	Phase1	GND
Module Rdson Q4	Phase2	GND	Phase2	GND

TEMPERATURE SENSE (NTC THERMISTOR)

Parameter		Min	Тур	Max	Unit
Voltage	Current = 1 mA, Temperature 25°C	7.5	-	12	V

THERMAL RESISTANCE

Parameter		Min	Тур	Max	Unit
Rthjc: Thermal Resistance Junction to case, Single Inverter FET	Q1, Q2, Q3, Q4 Thermal Resistance J-C	1	1	0.19	°C/W

^{2.} All bare die MOSFETs have same die size and same level of Rdson value. However the different Rdson values listed in the datasheet are due to the different access points available inside the module for Rdson measurement. Q3 and Q4 (Low side FETs) has the shortest Rdson measurement path in the layout. For exact FET rdson, it is recommended to use the Rdson value of Q3 or Q4 for the Kelvin pin with min impact of measurement path. Here Pure Rdson values of Q1,Q2,Q3,Q4 are from Q3 and Q4 measurement from NXV08H400XT1 datasheet. This value to be used for the actual MOSFET Rdson for Power loss and Temperature simulations.

^{3.} Module Rdson means total resistance of the measurement path btw Power terminals, referring to the resistance measurement methods table.

ISOLATION VOLTAGE (Isolation voltage between the Base plate and to control pins or power terminals.)

Test	Test Condition	Test Time	Min	Max	Unit
Leakage @ Isolation Voltage (Hi-Pot)	VAC = 3 kV	Time = 1 s	-	250	μΑ

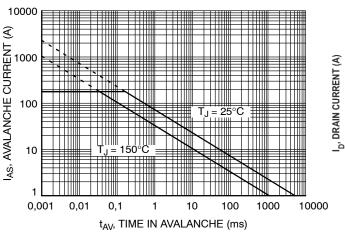
$\textbf{DYNAMIC AND SWITCHING CHARACTERISTICS} \ (T_J = 25^{\circ}C \ unless \ otherwise \ noted)$

Symbol	Parameter	Condition	Min	Тур	Max	Unit
YNAMIC C	HARACTERISTICS	•	•	•		
C _{iss}	Input Capacitance	V _{DS} = 40 V, V _{GS} = 0 V, f = 750 kHz	-	30,150	-	pF
C _{oss}	Output Capacitance		-	4,505	-	pF
C _{rss}	Reverse Transfer Capacitance	7	-	77	-	pF
Rg	Gate Resistance	f = 750 kHz	-	4.3	-	Ω
Q _{g(tot)}	Total Gate Charge	V _{GS} = 0 to 12 V, I _D =160 A	-	502	-	nC
Q _{gs}	Gate to Source Gate Charge		-	193	-	nC
Q_{gd}	Gate to Drain "Miller" Charge		-	89	-	nC
WITCHING	CHARACTERISTICS					
t _{on}	Turn-On Time	V _{DD} = 48 V, I _D = 400 A	-	710	-	ns
t _{d(on)}	Turn-On Delay Time	$V_{GS} = 12 \text{ V'}, R_{G}(\text{on/off}) = 15/15 \Omega$	-	235	-	ns
t _r	Turn-On Rise Time		-	475	-	ns
t _{d(off)}	Turn-Off Delay Time		-	608	-	ns
t _f	Turn-Off Fall Time		-	290	-	ns
t _{off}	Turn-Off Time		-	898	-	ns
RAIN-SOL	JRCE DIODE CHARACTERISTICS					
t _{RR}	Reverse Recovery Time	$V_{DD} = 48 \text{ V} \cdot I_D = 400 \text{ A}$	-	59	-	ns
Q _{RR}	Reverse Recovery Charge	$V_{GS} = 12 \text{ V, } R_{G}(\text{on/off}) = 15/15 \Omega$	_	1433	-	nC

COMPONENTS

Component	Description	Туре	Qty.	Specification
MOSFET	Bare Die	Bare Die	4	80 V 0.58 mΩ
NTC	10 kΩ ±1% 1,600 x 800 μm	Discrete	1	B-Constant B _{25/50} = 3380K B _{25/85} = 3435K B _{25/100} = 3455K
Capacitor (Snubber)	1,800 x 800 μm	Discrete	2	15 nF
Resistor (Snubber)	2,000 x 1,250 μm	Discrete	2	1 Ω

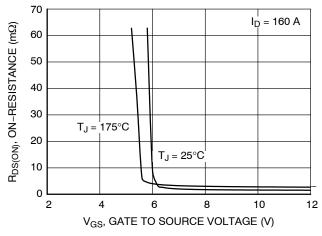
TYPICAL CHARACTERISTICS



1000 VGS = 14V Top 900 VGS = 12V VGS = 10V 800 VGS = 8V VGS = 6V Bottom 700 600 500 400 300 200 100 0 0.4 0.6 0.8 1.4 V_{DS}, DRAIN TO SOURCE VOLTAGE (V)

Figure 3. Unclamped Inductive Switching Capability

Figure 4. Saturation Characteristics



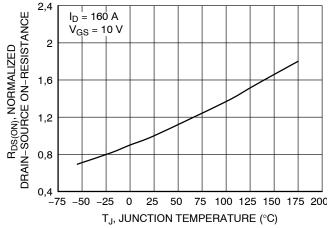
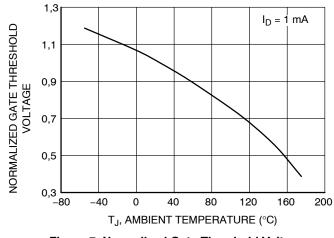


Figure 5. R_{DSON} vs. Gate Voltage

Figure 6. R_{DSON} vs. Temperature



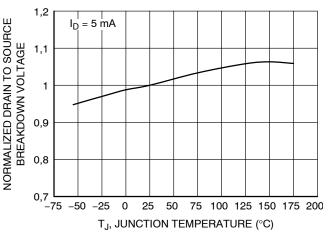


Figure 7. Normalized Gate Threshold Voltage vs. Temperature

Figure 8. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

TYPICAL CHARACTERISTICS (continued)

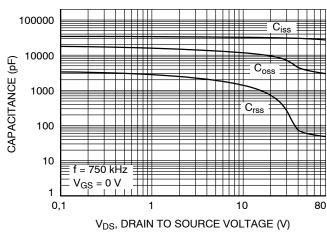


Figure 9. Capacitance vs. Drain to Source Voltage

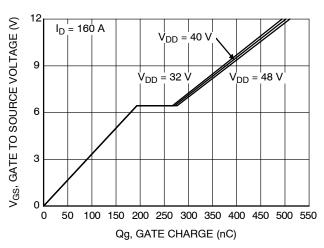


Figure 10. Gate Charge vs. Drain to Source Voltage

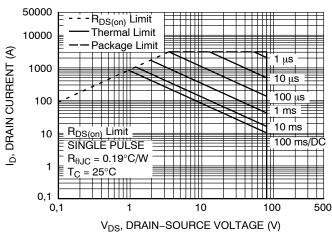


Figure 11. Safe Operating Area

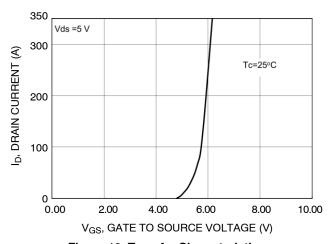


Figure 12. Transfer Characteristics

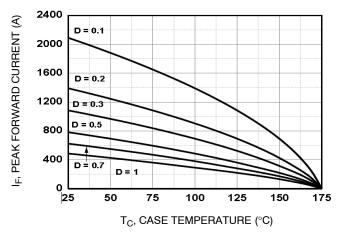
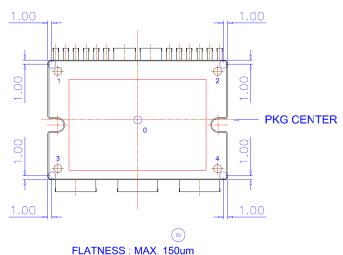


Figure 13. Body Diode Current



- MEASURING AT INDICATING POINTS 1, 2, 3, AND 4 (BASED ON "0")

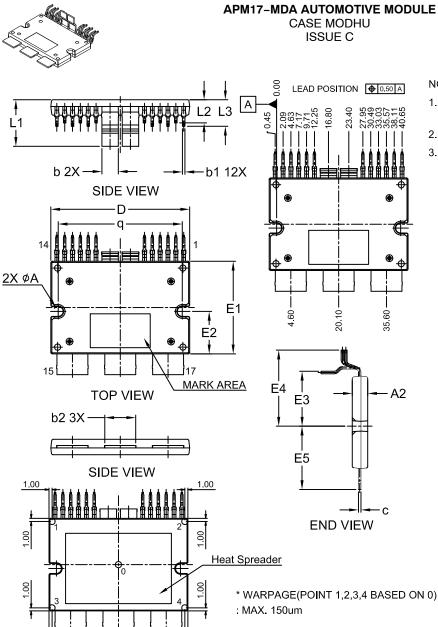
Figure 14. Flatness Measurement Position

MECHANICAL CHARACTERISTICS AND RATINGS

Parameter	Test Conditions	Min	Тур	Max	Units
Device Flatness	Refer to the package dimensions	0	-	150	um
Mounting Torque	Mounting screw: M3, recommended 0.7 N∙m	0.4	-	1.4 (Note 4)	N∙m
Weight		-	21.2	_	g

^{4.} Max Torque rating can be different by the type of screw, such as the screw head diameter, use or without use of Washer. In case of special screw mounting method is applied, contact to ON Semiconductor for the proper information of mounding condition.

PACKAGE DIMENSIONS



1.00

BOTTOM VIEW

1.00

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.

	MILLIMETERS				
DIM	MIN.	NOM.	MAX.		
A2	4.90	5.00	5.10		
b	5.20	5.30	5.40		
b1	0.70	0.80	0.90		
b2	9.90	10.00	10.10		
O	0.75	0.80	0.90		
D	44.90	45.00	45.10		
E1	29.90	30.00	30.10		
E2	13.65	13.75	13.85		
E3	17.50	17.80	18.10		
E4	24.35	24.65	24.95		
E5	20.20	20.50	20.80		
L1	14.80	15.10	15.40		
L2	7.20	7.50	7.80		
L3	8.30	8.60	8.90		
р	40.10	40.20	40.30		
φA	3.10	3.20	3.30		

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